Document Number: AFT27S012N Rev. 0, 07/2017

VRoHS

RF Power LDMOS Transistor

N-Channel Enhancement-Mode Lateral MOSFET

This 1.26 W RF power LDMOS transistor is designed for cellular base station applications covering the frequency range of 728 to 2700 MHz.

• Typical Single-Carrier W-CDMA Performance: V_{DD} = 28 Vdc, I_{DQ} = 90 mA, P_{out} = 1.26 W Avg., Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.⁽¹⁾

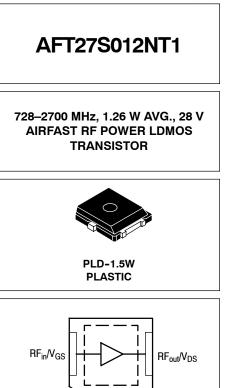
2100 MHz

Frequency	G _{ps} (dB)	η _D (%)	Output PAR (dB)	ACPR (dBc)	IRL (dB)
2110 MHz	20.8	22.0	9.8	-41.1	-9
2140 MHz	20.9	22.6	9.6	-40.7	-10
2170 MHz	20.9	22.8	9.4	-40.8	-10
2200 MHz	20.8	22.9	9.3	-40.4	-9

1. All data measured in fixture with device soldered to heatsink.

Features

- Greater negative gate-source voltage range for improved Class C operation
- · Designed for digital predistortion error correction systems
- Universal broadband driven device with internal RF feedback





Note: The center pad on the backside of the package is the source terminal for the transistor.

Figure 1. Pin Connections



Table 1. Maximum Ratings

Rating				Unit
	V _{DSS}	-0.5	, +65	Vdc
	V _{GS}	-6.0	, +10	Vdc
	V _{DD}	32	, +0	Vdc
	T _{stg}	-65 to	o +150	°C
	T _C	-40 to	o +150	°C
	TJ	-40 to	o +150	°C
	Symbol	Valu	e ^(2,3)	Unit
Hz	$R_{ extsf{ heta}JC}$	3	.4	°C/W
				•
	Class			
	1B			
Charge Device Model (per JESD22-C101)				
Rating	Package Peak Temperature U			Unit
3	260			°C
oted)				
Symbol	Min	Тур	Max	Unit
I _{DSS}	—	—	10	μAdc
I _{DSS}	—	_	1	μAdc
I _{GSS}	—	—	1	μAdc
	1			1
V _{GS(th)}	0.8	1.2	1.6	Vdc
V _{GS(Q)}	1.5	1.8	2.3	Vdc
	Rating 3 oted) Symbol IDSS IDSS IGSS	Note VGS VDD Tstg TC TJ Symbol Hz Rating Package 3 oted) Symbol Min IDSS IDSS IDSS IDSS VGS(th) 0.8	$\begin{tabular}{ c c c c } \hline V_{DSS} & -0.5 \\ \hline V_{GS} & -6.0 \\ \hline V_{DD} & 32, \\ \hline T_{stg} & -65 tc \\ \hline T_{C} & -40 tc \\ \hline T_{J} & -40 tc \\ \hline \end{bmatrix} \\ \hline \hline T_{J} & -40 tc \\ \hline \end{bmatrix} \\ \hline \hline \\ \hline$	Vorse -0.5, +65 VGS -6.0, +10 VDD 32, +0 Tstg -65 to +150 TC -40 to +150 T_J -40 to +150 T_J -40 to +150 Rating ReJC Symbol Value (2,3) Hz Reing Rating Package Peak Temperature 3 260 otted) Min Typ Ibss - 10 Ibss - 1 Ilgss - 1 VGS(th) 0.8 1.2 1.6

1. Continuous use at maximum temperature will affect MTTF.

MTTF calculator available at <u>http://www.nxp.com/RF/calculators</u>.
Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <u>http://www.nxp.com/RF</u> and search for AN1955.

(continued)

Table 5. Electrical Characteristics ($T_A = 25^{\circ}C$ unless otherwise noted) (continued)

Characteristic		Symbol	Min	Тур	Мах	Unit		
-								

Functional Tests (In NXP Test Fixture, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ} = 90$ mA, $P_{out} = 1.26$ W Avg., f = 2170 MHz, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ ± 5 MHz Offset.

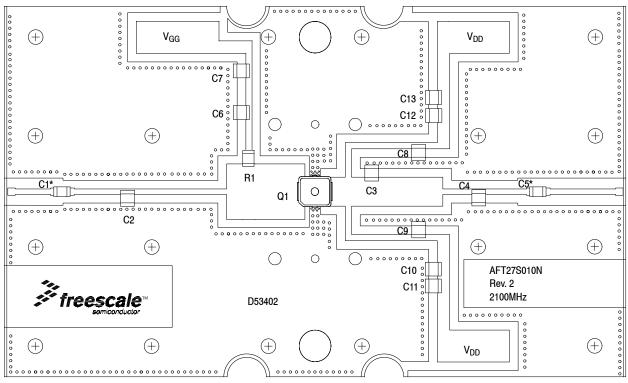
Power Gain	G _{ps}	20.0	20.9	_	dB
Drain Efficiency	η _D	18.5	22.8	_	%
Adjacent Channel Power Ratio	ACPR	—	-40.8	-37.9	dBc
Input Return Loss	IRL	—	-12	-9	dB
Load Mismatch (In NXP Test Fixture, 50 ohm system) I _{DQ} = 90 mA, f = 2140 MHz					

VSWR 10:1 at 32 Vdc, 16.6 W CW Output Power No Device Degradation (3 dB Input Overdrive from 125 mW CW Rated Power) Typical Performance⁽¹⁾ (In NXP Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQ} = 90 mA, 2110-2200 MHz Bandwidth Pout @ 1 dB Compression Point, CW P1dB W 13 0 AM/PM Φ -13 ____ (Maximum value measured at the P3dB compression point across the 2110-2200 MHz frequency range.) Gain Flatness in 90 MHz Bandwidth @ Pout = 1.26 W Avg. 0.20 dB G_F dB/°C ΔG 0.004 Gain Variation over Temperature (-30°C to +85°C) Output Power Variation over Temperature $\Delta P1dB$ 0.010 dB/°C (-30°C to +85°C)

Table 6. Ordering Information

Device	Tape and Reel Information	Package
AFT27S012NT1	T1 Suffix = 1000 Units, 16 mm Tape Width, 7-inch Reel	PLD-1.5W

1. All data measured in fixture with device soldered to heatsink.



*C1 and C5 are mounted vertically.

NOTE: All data measured in fixture with device soldered to heatsink. AFT27S012N uses the AFT27S0101N production fixture; board and parts list are identical.

Figure 2. AFT27S010NT1	Test Circuit Component La	yout — 2110-2200 MHz
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Part	Description	Part Number	Manufacturer
C1, C5, C6, C8, C9	9.1 pF Chip Capacitors	ATC100B9R1JT500XT	ATC
C2 1.1 pF Chip Capacitor		ATC100B1R1JT500XT	ATC
C3	2.0 pF Chip Capacitor	ATC100B2R0JT500XT	ATC
C4	1.0 pF Chip Capacitor	ATC100B1R0JT500XT	ATC
C7, C10, C11, C12, C13	10 μF Chip Capacitors	GRM32ER61H106KA12L	Murata
Q1	RF Power LDMOS Transistor	AFT27S010N	NXP
R1	2.37 Ω Chip Resistor	CRCW12062R37FKEA	Vishay
PCB	Rogers RO4350B, 0.020″, ε _r = 3.66	D53402	MTL

Table 7 AFT27S010NT1 Test Circuit Com	ponent Designations and Values — 2110-2200 MHz
	ipolient Designations and values — 2110-2200 Minz

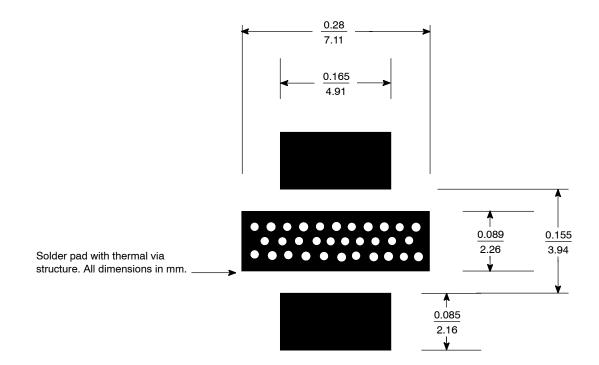
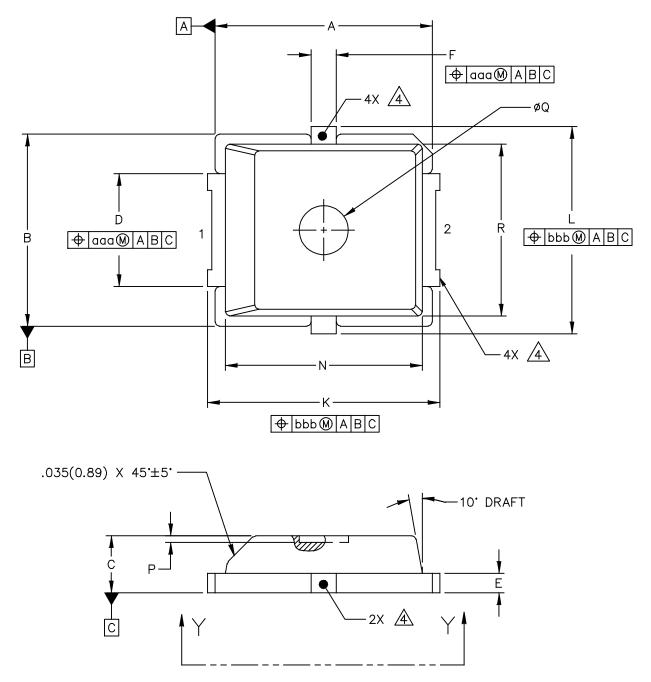


Figure 3. PCB Pad Layout for PLD-1.5W



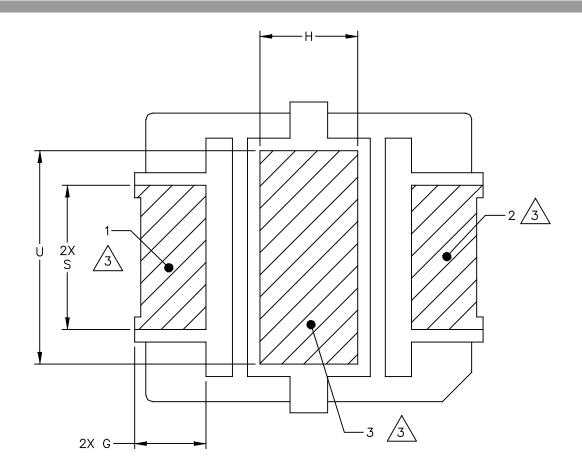
Figure 4. Product Marking

PACKAGE DIMENSIONS



© NXP SEMICONDUCTORS N.V. ALL RIGHTS RESERVED	MECHANICAL OUTLINE		PRINT VERSION NO	T TO SCALE
TITLE:		DOCUME	NT NO: 98ASA00476D	REV: A
PLD-1.5W		STANDAF	RD: NON-JEDEC	
		SOT1811-	-2	08 FEB 2016

AFT27S012NT1



VIEW Y-Y

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TITLE:		DOCUME	NT NO: 98ASA00476D	REV: A
PLD-1.5W		STANDAF	RD: NON-JEDEC	
		SOT1811-	-2	08 FEB 2016

NOTES:

- 1. CONTROLLING DIMENSION: INCH.
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.

 $\sqrt{3}$

HATCHING REPRESENTS THE EXPOSED AND SOLDERABLE AREA. DIMENSIONS G, S, H AND U REPRESENT THE VALUES BETWEEN THE TWO OPPOSITE POINTS ALONG THE EDGES OF EXPOSED AREA.

4. THESE SURFACES ARE NOT PART OF THE SOLDERABLE SURFACES AND MAY REMAIN UNPLATED.

	IN	СН	MII	LIMETER		INCH		мшт	METER
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	.255	.265	6.48	6.73	Q	.055	.063	1.40	1.60
В	.225	.235	5.72	5.97	R	.200	.210	5.08	5.33
С	.065	.072	1.65	1.83	S	.110	_	2.79	-
D	.130	.150	3.30	3.81	U	.156	_	3.96	-
E	.021	.026	0.53	0.66	aaa		.004	c).10
F	.026	.044	0.66	1.12	bbb		.005	c).13
G	.038	_	0.97	_					
Н	.069	_	1.75	_					
J	.160	.180	4.06	4.57					
К	.273	.285	6.93	7.24					
L	.245	.255	6.22	6.48					
N	.230	.240	5.84	6.10					
Р	.000	.008	0.00	0.20					
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TITLE:						DOCUMEN	NT NO: 98ASAC	0476D	REV: A
PLD-1.5W						STANDAR	D: NON-JEDEC	2	
						SOT1811-	-2	08	FEB 2016

AFT27S012NT1

PRODUCT DOCUMENTATION

Refer to the following resources to aid your design process.

Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

• EB212: Using Data Sheet Impedances for RF LDMOS Devices

To Download Resources Specific to a Given Part Number:

- 1. Go to http://www.nxp.com/RF
- 2. Search by part number
- 3. Click part number link
- 4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	July 2017	Initial release of data sheet

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